

**METHOD AND APPARATUS FOR TESTING
AN OPTICAL COMPONENT**

FIELD OF THE INVENTION

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The present invention relates to the field of optical component testing and, more specifically, to a method and apparatus for verifying connection paths through a switch fabric.

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BACKGROUND OF THE INVENTION

Photonic switches are used in order to redirect and transmit optical traffic signals between nodes of an optical network. At the heart of a photonic switching network lies a photonic switch fabric, which provides switching of optical traffic signals without the need for conversion of the signals to electrical form. Therefore, it is important to know when the switch fabric is no longer working properly since it will affect the workings of the network. As such, it is important to frequently verify the integrity of the connection paths within the switch fabric in order to ensure that the switch fabric is switching the optical traffic signals according to a desired mapping, and to further ensure that the power loss of the signals passing through the connection paths does not exceed an acceptable level.

A common method of testing switch fabrics is to inject an extraneous optical test signal into a particular connection path of the switch fabric and take measurements of that extraneous optical test signal both

before and after it has been injected into the switch fabric. By comparing the level of similarity of the measurements taken before and after the extraneous optical test signal has traveled through the particular connection path, the validity and power loss of the particular connection path can be determined.

However, a deficiency with the aforementioned method of verifying switch fabric connection paths is that the verification process can only take place while the connection path is not being used as an active connection path. Therefore, in order to test a selected connection path, the extraneous optical test signal must be injected within a connection path that is not being used to transmit an optical traffic signal. As such, a switch fabric connection path cannot both be tested and convey an optical traffic signal at the same time.

A further deficiency with the aforementioned method of switch fabric verification is that additional hardware components must be provided in order to generate the extraneous optical test signal. These additional components include, at a minimum, a source of extraneous light, which takes up space. Moreover, these additional components add to the cost of the photonic switch.

It can be seen that there is a need in the industry for an improved technique for performing switch fabric verification.

SUMMARY OF THE INVENTION

The present invention relates to a system for testing the connection paths of a switch fabric by using a spontaneously emitted signal as a test signal.

5 Accordingly, as embodied and broadly described herein, the present invention provides a system for testing an optical component. The system includes at least one first module and at least one second module, wherein each one of the second modules is associated to
10 one of the first modules. Each of the first modules is capable of obtaining a respective first measurement of a characteristic of a spontaneously emitted signal that is supplied to the optical component, and each of the second modules is capable of obtaining a respective second
15 measurement of the characteristic of the spontaneously emitted signal for which a respective first measurement was obtained by its associated first module. The respective second measurement is obtained upon receipt of the spontaneously emitted signal from the optical
20 component. The system further includes a processing module that is in communication with each of the first modules and each of the second modules for determining a feature of the optical component based on the first and second measurements.

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In a non-limiting embodiment of the present invention, the spontaneously emitted signal may be generated by an optical amplifier, the optical amplifier also functioning to amplify a plurality of optical
30 traffic signals.

Advantageously, the above-described system avoids the need for additional hardware components for producing

a test signal, and enables the connection paths of the switch fabric to be both tested and able to convey optical traffic signals at the same time.

5 As further embodied and broadly described herein, the present invention provides a system as described above, further including the optical component.

10 As still further embodied and broadly described herein, the present invention provides a method for testing an optical component. The method involves obtaining at a first module a first measurement of a characteristic of a spontaneously emitted signal that is to be supplied to the optical component. Once the first
15 measurement is obtained, the method further involves receiving at a second module the spontaneously emitted signal from the optical component. A second respective measurement is then obtained at a second module associated to the first module. The respective second
20 measurement is a measurement of the characteristic of the spontaneously emitted signal for which the first respective measurement of the characteristic was obtained at the associated first module. The respective second measurement is obtained upon reception of the
25 spontaneously emitted signal from the optical component. Finally, the method involves comparing the first and second respective measurements of the characteristic of the spontaneously emitted signal taken at the first and second modules to determine a feature of the optical
30 component.

BRIEF DESCRIPTION OF THE DRAWINGS

A detailed description of examples of implementation of the present invention is provided herein below with
5 reference to the following drawings, in which:

Figure 1 shows, in block diagram form, a system for testing an optical component in accordance with a specific embodiment of the present invention;

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Figure 2 shows an expanded view of a tributary line card in the system of Figure 1;

Figure 3 shows a block diagram of a process for determining the validity of a selected connection path in accordance with a specific embodiment of the present invention;

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Figure 4 is a block diagram of the process for determining if a successful communication has been established over the selected connection path; and

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Figure 5 shows a computing unit for implementing a processing module in accordance with a specific embodiment of the present invention.

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In the drawings, embodiments of the invention are illustrated by way of example. It is to be expressly understood that the description and drawings are only for the purposes of illustration, and are not intended to be a definition of the limits of the invention.

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DETAILED DESCRIPTION

Shown in Figure 1 is a system 100 for testing an optical component in accordance with a specific embodiment of the present invention. For the purposes of this description, the optical component in question is a photonic switch fabric 108. It should, however, be understood that the present invention can be used for testing other optical components without departing from the spirit of the invention.

System 100 includes a plurality of ingress modules 112, a plurality of egress modules 114, and a processing module 116 that is in communication with the ingress modules 112 and the egress modules 114 through communication lines 136. Although a plurality of ingress modules 112 and a plurality of egress modules 114 are shown in Figure 1, it should be understood that a system 100 that includes only a single ingress module 112 and a single egress module 114 in communication with the processing module 116 is also within the scope of the present invention.

In the specific example of implementation shown in Figure 1, the plurality of ingress modules 112 and the plurality of egress modules 114 are distributed amongst three photonic line cards 102, 104 and 106. Although three line cards are shown, more or fewer line cards can be included without departing from the spirit of the invention. In addition, the distribution of ingress and egress modules 112, 114 amongst the respective line cards can also vary. For example, the line cards can include only first modules, as in the case of line card 102, only

egress modules 114, as in the case of line card 106, or both ingress and egress modules 112 and 114, as in the case of line card 104.

5 Line cards 102, 104 and 106 shown in Figure 1 can be referred to as photonic trunk line cards. These can be equipped with ingress optical amplifiers 120, egress optical amplifiers 121 and multiplexers 122. Photonic trunk line cards are so termed because of their ability
10 to receive light of multiple wavelengths from a network fiber, and separate the multiple wavelength light into multiple single wavelength lights using the multiplexer 122, for example. A multiplexer 122 may also be used for the purpose of combining multiple single wavelength
15 lights into a multiple wavelength light to a network fiber, such a usage being indicated within the line card 104 by the multiplexer 122 that is connected to the egress amplifier 121. For the purpose of this invention, a multiplexer 122 shall thus be understood to contain the
20 function of combining wavelengths, or the function of separating wavelengths, or the function of both combining and separating wavelengths.

 Alternatively, photonic tributary line cards can be
25 used for the purposes of this invention. Figure 2 shows an example of a photonic tributary line card 124 including an ingress optical amplifier 120, an egress optical amplifier 121, three ingress modules 112 and three egress modules 114. Photonic tributary line cards
30 are able to receive light from several network fibers, each network fiber carrying an optical traffic signal occupying only one wavelength. As such, in the case of photonic tributary line cards, a wavelength division

multiplexer is not required.

In the cases of both the trunk line cards 102, 104 and 106 and the tributary line cards 124, the optical traffic signal or signals being received at the ingress modules 112 have passed through an ingress optical amplifier 120, which has the effect of creating optical noise and adding the optical noise, otherwise known as an amplified spontaneous emission (ASE), to the optical traffic signal travelling therethrough. It should be understood that the ingress optical amplifier 120 creates noise that will appear on the optical fiber entering the switch fabric 108, regardless of whether there is actually any optical traffic signal travelling through the optical fiber. In accordance with an embodiment of the present invention, it is this omnipresent amplified spontaneous emission that is used as a test signal to verify the operation of the switch fabric 108. It should be understood that any spontaneously emitted signal can be used as the test signal, and that the test signal does not necessarily have to be the industry accepted amplified spontaneous emission (ASE).

From the above description, it will be apparent to one skilled in the art that the ingress optical amplifier 120 may advantageously function both as a source of the spontaneously emitted light for the test signal and as an amplifier of the optical traffic signals.

Different types of optical amplifiers known in the art can be used as the ingress optical amplifiers 120 for the purposes of this invention. Some non-limiting examples of suitable ingress optical amplifiers include

erbium-doped fiber amplifiers (EDFAs), semiconductor optical amplifiers (SOAs), Raman amplifiers and erbium-doped waveguide amplifiers (EDWAs). The only requirement of an "ingress optical amplifier" 120, for the purposes
5 of this invention, is that it produce ASE, which is the case with all of the aforementioned amplifiers and others known to those of ordinary skill in the art. In addition, it should be understood that the ingress optical amplifiers 120 need not be positioned on the line
10 cards 102, 104, 106. The only requirement for the position of an ingress optical amplifier 120, for the purposes of this invention, is that it be located "before" an ingress module 112, such that the ingress module 112 can obtain a measurement of the ASE..

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It should be further understood that the ingress optical amplifiers 120 and egress optical amplifiers 121 may each consist of a single amplifying element, or may consist of multiple amplifying elements in parallel, and
20 that each amplifying element may itself consist of a plurality of sequential amplifying stages.

It should be understood that although the ingress modules 112 and egress modules 114 shown in Figures 1 and
25 2 are embedded within photonic line cards, this is not a necessary requirement for the operation of the invention. Instead, the ingress and egress modules 112, 114 can be located elsewhere. For example, the ingress and egress modules 112, 114 can be positioned between the line cards
30 102, 104, 106 and the switch fabric 108, or alternatively, there may be no line cards at all, and the ingress and egress modules 112, 114 can be stand-alone modules. In the case where there are no line cards, the

ingress and egress modules 112, 114 could include their own ingress optical amplifiers 120 and multiplexers 122, as required.

5 As mentioned above, in the specific example of implementation described herein, the optical component being tested is a photonic switch fabric 108. A switch controller 138 is connected to the photonic switch fabric 108 and is able to selectively establish connection paths
10 110 within the photonic switch fabric 108 for conveying optical traffic signals. The switch controller 138 is further adapted to communicate with the processing module 116 in order to inform the processing module 116 of which ingress module 112 and which egress module 114 are
15 associated to which connection path 110. Photonic switch fabrics 108 and switch controllers 138 are well known in the art and as such will not be described in further detail herein.

20 In operation, the ingress modules 112 are adapted to obtain a first measurement of a characteristic of the amplified spontaneous emission created by the ingress optical amplifier 120, prior to the amplified spontaneous emission being supplied to the switch fabric 108. In the
25 specific example of implementation shown in Figures 1 and 2, ingress modules 112 include an optical tap 123 for diverting a portion of the amplified spontaneous emission towards an optical monitor 128. The optical monitor 128 is able to obtain a first measurement of a characteristic
30 of the amplified spontaneous emission. Preferably, the optical monitor 128 has a high dynamic range since the ASE, in general, is designed to be much lower than the power of the optical traffic signal. Therefore, in one

specific example of implementation, the optical monitor 128 is an optical power monitor with a dynamic range of greater than 30dB. The characteristic of the amplified spontaneous emission that is measured by the optical
5 monitor 128 may thus be the power or intensity of the amplified spontaneous emission.

Each ingress module 112 is associated to an egress module 114 by virtue of an associated connection path 110
10 through the optical component. As such, the amplified spontaneous emission travels through a connection path 110 associated to the particular ingress module 112 that obtained the first measurement of the characteristic of the amplified spontaneous emission. Once the amplified
15 spontaneous emission has traveled through the associated connection path 110, it is intercepted by the egress module 114 associated to that connection path 110. The egress module 114 is adapted to obtain a second measurement of the amplified spontaneous emission for
20 which the associated ingress module 112 took a first measurement. In the specific example of implementation shown in Figures 1 and 2, each of the egress modules 114 also includes an optical tap 126 for diverting a portion of the amplified spontaneous emission towards an optical
25 monitor 132. The optical monitor 132 then obtains a second measurement of a characteristic of the amplified spontaneous emission. For the same reasons as explained with respect to the optical monitors 128, in a specific example of implementation, the optical monitors 132 have
30 a dynamic range of greater than 30dB.

With reference to Figure 3, a first verification operation of the processing module 116 will be described.

As stated above, processing module 116 is adapted to be in communication with the plurality of ingress modules 112 and the plurality of egress modules 114 through communication lines 136. As such, it is the processing module 116 that decides which connection path 110 through switch fabric 108 will be verified or tested at any given time. In order to do so, the processing module 116 obtains from the ingress and egress modules 112, 114 the first and second measurements of the characteristic of the amplified spontaneous emission that traveled the selected connection path 110. At step 304 the processing module 116 evaluates the degree of similarity between the two measurements in order to determine a feature of the switch fabric 108.

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In one specific embodiment of the present invention, the feature of the switch fabric 108 being determined is the power loss across a selected connection path 110. In such cases the degree of similarity between the first and second measurements evaluated by the processing module 116 is the actual power loss over the connection path.

In a further specific embodiment of the present invention, the feature of the switch fabric 108 that is determined by the processing module 116 is the validity of the selected connection path 110.

As a specific example of implementation, the degree of similarity between the first measurement and the second measurement is evaluated by subtracting the second measurement from the first measurement. Alternatively, the degree of similarity can be evaluated by taking a ratio of the first measurement to the second measurement.

It should however be understood that any other method of evaluating a degree of similarity between the two measurements could be used without departing from the spirit of the invention.

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Once the degree of similarity between the first and second measurements has been established, the processing module 116 compares the degree of similarity evaluated to a predetermined range of values. It should be understood that for the purposes of this application, the term "a predetermined range of values" can include one or more discrete values or a continuum between two chosen values. If the degree of similarity evaluated falls within the predetermined range, then the processing module 116 determines at step 308 a first feature of the switch fabric 108, such as the feature of a valid connection path 110. Alternatively, if the degree of similarity evaluated falls outside the predetermined range, then the processing module 116 determines at step 306 a second feature of the switch fabric, such as an invalid connection path or an invalid power loss.

A specific, non-limiting example of a predetermined range against which the degree of similarity is compared could be the value "zero". In the cases where the degree of similarity is obtained by taking the difference between the first measurement and the second measurement, a value of zero denotes that the value of the first measurement is exactly the same as the value of the second measurement. This could result in the processing module 116 determining that the selected connection path 110 is valid. Alternatively, if the difference between the first measurement and the second measurement is very

high, and well outside the predetermined range of zero, it would denote that the second measurement was very low or non-existent. This could result in the processing module 116 determining that the selected connection path
5 110 is invalid.

In an alternative embodiment, the processing module 116 does not require a first measurement of the characteristic of the amplified spontaneous emission to
10 be taken in order to determine the validity of a selected connection path. In a specific example of implementation, the absence of a first measurement could be permitted when the amplified spontaneous emission entering the switch fabric 110 is of a known value. In such cases, the
15 processing module simply determines a degree of similarity between the second measurement obtained at the egress module and a reference value. If the degree of similarity falls within a predetermined range of values, then the processing module 116 concludes validity of the
20 power loss of the selected connection path, and if the degree of similarity falls outside the predetermined range of values, then the processing module 116 concludes invalidity of the power loss of the selected connection path. For example, if the characteristic being measured
25 is power, and the predetermined range is 150 to 170 picoWatts (pW), then if the degree of similarity is found to be 168pW, the processing module 116 determines a valid power loss of the connection path, however, if the degree of similarity is found to be zero, which falls outside of
30 the predetermined range, the processing module 116 determines an invalid power loss of the connection path.

For the purposes of this application the term

"validity of the connection path" refers to the completed travel of an amplified spontaneous emission through the selected connection path 110. Therefore, when a selected connection path is determined to be valid, it means that the amplified spontaneous emission was able to travel from the ingress module 112 to the egress module 114 associated to the selected connection path. However, when a selected connection path is determined to be invalid, it means that the amplified spontaneous emission was unable to travel from the ingress module 112 to the egress module 114 associated to the selected connection path. Further, the term "validity of the power loss" indicates that sufficient amplified spontaneous emission was able to travel to the egress module, and the term "invalidity of the power loss" indicates that insufficient amplified spontaneous emission was received at the egress module 114. Thus, as non-limiting examples, a selected connection path may be invalid, indicating a mis-connection; a selected connection path may have invalid power loss, indicating that the connection has been established correctly but is of performance below a previously defined specification; a selected connection path may have a valid connection path and a valid power loss, indicating that the connection path is fit for use.

In a further specific example of implementation, the ingress optical amplifiers 120 are able to insert individual modulation signatures on each of the amplified spontaneous emissions being supplied to the switch fabric 108. As such, the processing module 116 is able to determine a first modulation signature at an ingress module 112 associated to a selected connection path, and

is able to determine a second modulation signature at the egress module 114 associated to the same selected connection path 110. Specific non-limiting examples of modulation signatures include network-globally unique ID's, node-locally-unique ID's or non-unique ID's.

Using these modulation signatures, the processing module 116 is able to perform a second verification operation by comparing the two modulation signatures and establishing a degree of similarity therebetween. Based on the degree of similarity between the two modulation signatures, the processing module 116 is able to determine whether or not a successful communication over the selected connection path 110 actually took place. It should, however, be understood that the first and second verification operations can be performed contemporaneously.

Referring to Figure 4, a more detailed version of the second verification operation is described below. At step 402, the processing module 116 determines at an ingress module 112 associated to a selected connection path 110 a first modulation signature of an amplified spontaneous emission. At step 404, the processing module 116 determines at the egress module 114 whether a second modulation signature is present on the amplified spontaneous emission received from the switch 108. If no second modulation signature is present, the processing module determines at step 406 that there was a failed connection over the selected connection path 110, meaning that the amplified spontaneous emission for which a first modulation signature was determined at the ingress module 112 did not make it through the selected connection path

110 to the egress module 114.

Alternatively, if a second modulation signature is present at the egress module 114, the processing module 5 116 determines at step 408 whether or not the second modulation signature is the same as the first modulation signature determined at the associated ingress module 112. If it is determined at step 408 that the second modulation signature matches the first modulation 10 signature, the processing module 116 determines at step 410 that there was a successful communication over the selected connection path 110, meaning that the amplified spontaneous emission that entered the selected connection path 110 is the same amplified spontaneous emission that 15 exited the selected connection path 110. Alternatively, if the first and second modulation signatures are not the same, then the processing module 116 determines at step 412 that there is a mistaken connection over the selected connection path 110, meaning that the amplified 20 spontaneous emission that entered the selected connection path 110 is not the same amplified spontaneous emission that exited the selected connection path 110. This could be the result of two amplified spontaneous emissions getting mixed up within the switch fabric 108, or the 25 switch controller 138 providing incorrect information to the processing module 116 about which ingress module 112 and which egress module 114 are associated to the selected connection path 110.

30 Advantageously, the second verification operation enables the system to ascertain that the amplified spontaneous emission being measured at the first module 112 is in fact the same amplified spontaneous emission

being measured at the second module 114. This provides an additional level of assurance that the switch fabric 108 is operating properly.

5 Those skilled in the art should appreciate that in some embodiments of the invention, all or part of the functionality previously described herein with respect to the processing module 116 may be implemented as pre-programmed hardware or firmware elements (e.g.,
10 application specific integrated circuits (ASICs), electrically erasable programmable read-only memories (EEPROMs), etc.), or other related components.

 In other embodiments of the invention, all or part
15 of the functionality previously described herein with respect to the processing module 116 may be implemented as software consisting of a series of instructions for execution by a computing unit. The series of instructions could be stored on a medium which is fixed,
20 tangible and readable directly by the computing unit, (e.g., removable diskette, CD-ROM, ROM, PROM, EPROM or fixed disk), or the instructions could be stored remotely but transmittable to the computing unit via a modem or other interface device (e.g., a communications adapter)
25 connected to a network over a transmission medium. The transmission medium may be either a tangible medium (e.g., optical or analog communications lines) or a medium implemented using wireless techniques (e.g., microwave, infrared or other transmission schemes).

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 The computing unit implementing processing module 116 may be configured as a computing unit 500 of the type depicted in figure 5, including a processing unit 502 and

a memory 504 connected by a communication bus 506. The memory includes data 508 and program instructions 510. The processing unit 502 is adapted to process the data 508 and the program instructions 510 in order to
5 implement the procedures described in the specification. The computing unit 500 may also comprise I/O interfaces 512/514 for receiving or sending data elements to external devices. For example, in a specific example of implementation interface 512 is for receiving connection
10 path information from switch controller 138.

Those skilled in the art should further appreciate that the program instructions 510 may be written in a number of programming languages for use with many
15 computer architectures or operating systems. For example, some embodiments may be implemented in a procedural programming language (e.g., "C") or an object oriented programming language (e.g., "C++" or "JAVA").

20 It will be appreciated that the system for verifying an optical component as described above may be of a distributed nature where the connection path information is collected at one location and transmitted to a computing unit implementing the system 100 over a network.
25 The network may be any suitable network including but not limited to a global public network such as the Internet, a private network and a wireless network. In addition, the computing unit implementing the system 100 may be adapted to process multiple connection paths originating
30 from multiple optical components concurrently using suitable methods known in the computer related arts.

Although various embodiments have been illustrated, this was for the purpose of describing, but not limiting, the invention. Various modifications will become apparent to those skilled in the art and are within the scope of this invention, which is defined more particularly by the attached claims.